Using support vector machine techniques to correlate past and future large-cap stock returns

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Quantitative analysis of the stock market to predict future behavior has long been a very active area of study with clear applicability, both for profit-seeking and informing macroeconomic policy. We apply support vector machine techniques to show that simple daily total return data can be shown to be correlated with future performance. Although our method is not immediately applicable for predicting beyond the current moment in time, it demonstrates that the potential for such models does exist.

Additional Key Words and Phrases: Machine learning, Support Vector Machines, LibSVM, Stock prediction, S&P 500

ACM Reference Format:

1 DATA PROCESSING

1.1 Data

The economics department of Armstrong State University has a dataset spanning over 16 years of daily total returns for each stock listed in the Standard & Poor's 500 Index, which consists of 505 stocks from 500 of the largest companies in the world, measured by total market capitalization. We were given limited access to this data to perform the experiments for this project. The data takes the form of dated percentage daily total returns and occupies about 23.8 mibibytes (25 million bytes).

For each test, 10% of the data was randomly removed and used as a test set while the remaining 90% was used as a training set.

1.2 Training Labels

Labels for this undertaking were calculated from the excluded data from the test period, which was chosen as the final year of the data: March 22, 2016, to March 21, 2017. Each stock was labeled with whether its total return exceeded that of the S&P 500 index during that period.

1.3 Classifier

Our system uses the LibSVM library to implement SVM training and classification. It interacts with its programmatic Java API to add features like statistics tracking and training models with different parameters across different threads. Parameters were evaluated at multiple values from ranges recommended by the LibSVM authors.

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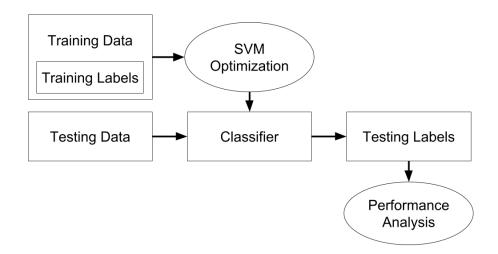


Fig. 1. Block diagram of classifier system.

Table 1. Classifier results: top 5 ROC-AUC.

C	Kernel	Accuracy	ROC-AUC	F_1 score	# Selected	Simulated Return
0.25	polynomial (degree 4)	0.820	0.821	0.824	25	35.6%
0.5	polynomial (degree 3)	0.820	0.821	0.824	25	36.0%
2	polynomial (degree 4)	0.820	0.819	0.830	27	34.3%
1	polynomial (degree 2)	0.820	0.819	0.830	27	35.6%
1	polynomial (degree 4)	0.820	0.819	0.830	27	34.3%

1.4 Prediction

Prediction quality was measured with a bevy of statistics. Accuracy is simple to calculate $(\frac{\text{correct classifications}}{\text{tested elements}})$.

rediction quality was measured with a bevy of statistics. Accuracy is simple to calculate (to tested elements). For binary criteria, more informative values can be generated. Use TP, FP, FN, and TN, to represent true positives, false positives, false negatives, and true negatives, respectively. Especially important are true positive rate $(TPR = \frac{TP}{TP+FN})$, true negative rate $(TNR = \frac{TN}{FP+TN})$, positive predictive value $(PPV = \frac{TP}{TP+FP})$, and negative predictive value $(NPV = \frac{TN}{FN+TN})$. "AUC" and F_1 score are discussed below.

Traditional two-class SVM does not have a sensitivity parameter, so it only creates one point on a Receiver Operating Characteristic (ROC) graph. We can trivially interpolate between that point and the points (0,0) and (1, 1) by imagining a series of classifiers that randomly choose with a certain probability whether to refer to our classifier or to automatically reject or accept, respectively (as in Fig. 2). (This is equivalent to 'convex hull' techniques, but for a single data point.) In this way, we get a curve and can calculate the area under it simply as $AUC = \frac{TPR + TNR}{2}$. The F_1 score is calculated as the harmonic mean of TPR and PPV:

$$F_1 = \frac{2}{\frac{1}{TPR} + \frac{1}{PPV}}$$

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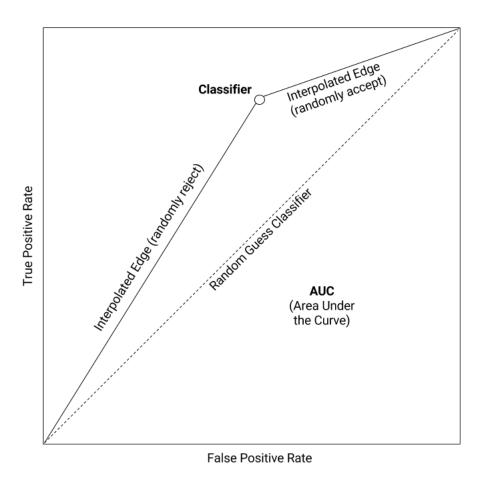


Fig. 2. Interpolated Receiver Operating Characteristic.

2 RESULTS AND PERFORMANCE

Table 1 gives performance statistics for different parameterizations of the classifier, chosen for the best "area under the curve" (for their interpolated receiver operating characteristic). Since every polynomial polynomial degree between 2 and 10 was tested, we see that quadratic, cubic, and quartic kernels give better results than a linear kernel, higher-degree polynomial kernels, or radial-basis function kernels. Also, a clear bias toward lower C values is observed. Each of these classifiers selected about half of the test set of size 50 to beat the market average, which is in line with expectations.

Table 2 shows the top-performers ranked by simulated return, which is calculated by imagining the total return (over the test period) for an investment split equally between each of the stocks the classifier recommended. We see a much different trend, where the highest possible returns are delivered by classifiers that managed to select very few stocks that each performed excellently. These classifiers are all based on radial-basis functions with low y and C values. Further research could help determine why radial-basis function kernels are uniquely suited to fixating on high-performing outliers on our dataset.

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Table 2. Classifier results: top 5 simulated returns.

C	Kernel	Accuracy	ROC-AUC	F_1 score	# Selected	Simulated Return
0.25	radial-basis ($\gamma = 0.2$)	0.520	0.538	0.143	2	66.8%
0.5	radial-basis ($\gamma = 0.1$)	0.620	0.635	0.424	7	62.0%
0.25	radial-basis ($\gamma = 0.5$)	0.500	0.518	0.138	3	50.3%
1	radial-basis ($\gamma = 0.1$)	0.580	0.591	0.432	11	44.9%
0.5	radial-basis ($\gamma = 0.2$)	0.580	0.591	0.432	11	44.9%

Table 3. Example classification of test set (C = 0.25, quartic kernel).

KR	-24.1%	WU	10.9%	AIZ	25.4%
MAT	-21.5%	NEM	12.8%	NOC	26.1%
KIM	-17.4%	FBHS	14.4%	HOG	28.1%
HRB	-13.1%	HD	15.9%	CBG	28.5%
BMY	-12.6%	BEN	17.2%	QRVO	29.5%
DLTR	-10.5%	HON	17.5%	COO	30.6%
SBUX	-7%	CVX	17.5%	CTXS	30.9%
AAP	-5.9%	S&P 500	17.5%	MPC	35.9%
DISCA	-1.9%	BWA	17.8%	YHOO	36.4%
GE	0.3%	LLY	19.5%	ATVI	45.5%
VRTX	3.7%	FTV	20%	ULTA	48.2%
ES	5.2%	CCL	20.1%	PRU	54.5%
WLTW	6.6%	MCO	20.3%	WDC	59.9%
CHRW	8.2%	KHC	20.7%	LRCX	61.1%
UPS	8.4%	KMX	23.2%	ZION	72.6%
LVLT	8.7%	ARNC	24.2%	CSX	79.8%
FOXA	9.3%	CELG	24.7%	MU	118.8%

Table 3 gives the specific results from the top-performing configuration ranked by ROC-AUC, as in Table 1. The stocks are sorted by increasing return during the test period, and those that were predicted to outperform the S&P 500 index have their tickers bolded. The few false positives (GE, LVLT, WU, and HON) are plainly visible, as are the false negatives (FTV, KHC, CBG, MPC, and ATVI). The index itself is italicized in approximately the middle of the list, where one would expect it.

3 DISCUSSION

3.1 Applications

Although we used 'foreknowledge' of the test period to train our model, these results do demonstrate that stocks that will outperform the market in the future could have similarities in their past performance that machine learning techniques can discuss. One application of this would be for someone with expert knowledge or insider information to label a training set of stocks. SVM optimization would create a model that could evaluate whether other stocks are 'like' the expert's picks. Another application could be to time-shift data and see if there are recognizable patterns in daily returns that repeat over intervals, which could potentially be projected into the future.

3.2 Conclusion

Machine learning techniques can be used to distinguish effectively between large-cap stocks that will and will not outperform the market over a specific period of time. SVM is particularly well-suited to this task because of its configurability and ability to effectively process large training sets with large numbers of features. Although our model was constructed using foreknowledge of stocks' performance, other, less absolute methods could be used to label training data for the same or similar purposes.

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